Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/828,946	FU, YEE-CHUNG	
Examiner	Art Unit	
Tamai I.E. Karl	2834	

	SEARCHED				
Class	Subclass	Date	Examiner		
310	309				
359	223-226				
	290,291				
257	415	12/2/2005	KIT		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
g02b026/08, g02b026/10	12/2/2005	КІТ		
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